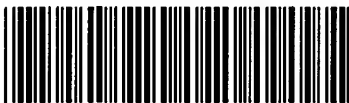


**Search Notes**

Application/Control No.

10/752,399

Examiner

Patrick Butler

Applicant(s)/Patent under  
Reexamination

CHANG ET AL.

Art Unit

1732

**SEARCHED**

Class	Subclass	Date	Examiner
264	103	5/16/2005	PB
264	211.14	5/16/2005	PB
264	130	5/16/2005	PB
264	211.17	5/16/2005	PB
264	210.8	5/16/2005	PB
264	210.5	5/16/2005	PB
Above	UPDATED	11/7/2005	PB
Above	UPDATED	6/9/2006	PB
Above	UPDATED	1/17/2007	PB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached EAST search history	5/13/2005	PB
conducted inventor search in PALM	5/16/2005	PB
consulted Leo Tentoni for 264	5/16/2005	PB
EAST(US-PGPUB; USOCR; USPAT; DERWENT; EPO; JPO; IBM_TDB) - See Search History Printout	11/7/2005	PB
EAST(US-PGPUB; USOCR; USPAT) - See Search History Printout	6/9/2006	PB
EAST(US-PGPUB; USOCR; USPAT) - See Search History Printout	1/17/2007	PB